

K1573-VB Datasheet

N-Channel 600 V (D-S) Super Junction Power MOSFET

| PRODUCT SUMMARY | | | | | | |
|----------------------------------|-----------------|------|--|--|--|--|
| V _{DS} (V) | 600 | | | | | |
| R _{DS(on)} at 25 °C (Ω) | $V_{GS} = 10 V$ | 0.23 | | | | |
| Q _g Typ. (nC) | 24 | | | | | |
| Q _{gs} (nC) | 6 | | | | | |
| Q _{gd} (nC) | 11 | | | | | |
| Configuration | Single | | | | | |

FEATURES

- Low figure-of-merit (FOM) Ron x Qa
- Low input capacitance (Ciss)
- Reduced switching and conduction losses
- Ultra low gate charge (Q_a)
- Avalanche energy rated (UIS)



TO-3P G G D D (TAB) S s

N-Channel MOSFET

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Industrial
 - Welding
 - Induction heating
 - Motor drives
 - Battery chargers
 - Renewable energy
 - Solar (PV inverters)

| ABSOLUTE MAXIMUM RATINGS ($T_C = 25 \text{ °C}$, unless otherwise noted) | | | | | | | | | |
|---|-------------------------|--|-----------------------------------|-------------|------|--|--|--|--|
| PARAMETER | | | SYMBOL | LIMIT | UNIT | | | | |
| Drain-Source Voltage | | | V _{DS} | 600 | v | | | | |
| Gate-Source Voltage | V _{GS} | ± 30 | v | | | | | | |
| Continuous Drain Current (T _J = 150 °C) | V _{GS} at 10 V | $V = \frac{T_{C} = 25 °C}{T_{C} = 100 °C}$ | - I _D | 15 | | | | | |
| | V _{GS} at 10 V | T _C = 100 °C | | 10 | А | | | | |
| Pulsed Drain Current ^a | | | I _{DM} | 45 | | | | | |
| Linear Derating Factor | | | | 1.4 | W/°C | | | | |
| Single Pulse Avalanche Energy ^b | | | E _{AS} | 286 | mJ | | | | |
| Maximum Power Dissipation | | | PD | 180 | W | | | | |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} | -55 to +150 | °C | | | | |
| Drain-Source Voltage Slope | T _J = 125 °C | | -1) (/ -14 | 37 | | | | | |
| Reverse Diode dV/dt ^d | | | dV/dt | 23 | V/ns | | | | |
| Soldering Recommendations (Peak Temperature) ^c | for 10 s | | | 300 | °C | | | | |

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature. b. $V_{DD} = 50$ V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 Ω , I_{AS} = 4.5 A.

c. 1.6 mm from case.

d. $I_{SD} \leq I_D$, dl/dt = 100 A/µs, starting T_J = 25 °C.



| THERMAL RESISTANCE RATI | NGS | | | | | | | | |
|--|-----------------------|--|--|----------------------------|------|-------|------|------|--|
| PARAMETER | SYMBOL | TYP. | MAX. | | | UNIT | | | |
| Maximum Junction-to-Ambient | R _{thJA} | - 62 | | | 0000 | | | | |
| Maximum Junction-to-Case (Drain) | R _{thJC} | - 0.7 | | | | °C/W | | | |
| | | | | | | | | | |
| SPECIFICATIONS (T _J = 25 $^{\circ}$ C, u | inless otherwi | se noted) | | | | | | | |
| PARAMETER | SYMBOL | TES | T CONDIT | IONS | MIN. | TYP. | MAX. | UNIT | |
| Static | | • | | | • | | | | |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} = | = 0 V, I _D = | 250 µA | 600 | - | - | | |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | Reference | e to 25 °C, | , I _D = 1 mA | - | 0.75 | - | V/°C | |
| Gate-Source Threshold Voltage (N) | V _{GS(th)} | V _{DS} = | = V _{GS} , I _D = | 250 µA | 2 | - | 4 | V | |
| | | $V_{GS} = \pm 20 V$ $V_{GS} = \pm 30 V$ | | - | - | ± 100 | nA | | |
| Gate-Source Leakage | I _{GSS} | | |) V | - | - | ± 1 | μA | |
| | | V _{DS} = | = 600 V, V ₀ | _{3S} = 0 V | - | - | 1 | | |
| Zero Gate Voltage Drain Current | IDSS | V _{DS} = 520 V | $V_{DS} = 520 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 125 \text{ °C}$ | | | - | 10 | μA | |
| Drain-Source On-State Resistance | R _{DS(on)} | V _{GS} = 10 V | | I _D = 8 A | - | 0.23 | - | Ω | |
| Forward Transconductance | g fs | V _{DS} | = 30 V, I _D | = 8 A | - | 5.6 | - | S | |
| Dynamic | | 1 | | | 1 | 1 | 1 | 1 | |
| Input Capacitance | C _{iss} | $V_{GS} = 0 V,$ $V_{DS} = 100 V,$ f = 1 MHz | | - | 1640 | - | pF | | |
| Output Capacitance | C _{oss} | | | - | 80 | - | | | |
| Reverse Transfer Capacitance | C _{rss} | | | - | 4 | - | | | |
| Effective Output Capacitance, Energy Related ^a | C _{o(er)} | $V_{DS} = 0 V $ to 520 V, $V_{GS} = 0 V$ | | - | 63 | - | | | |
| Effective Output Capacitance, Time Related ^b | C _{o(tr)} | | | - | 213 | - | | | |
| Total Gate Charge | Qg | V _{GS} = 10 V I _D = 8 A, V | | A, V _{DS} = 520 V | - | 24 | 48 | nC | |
| Gate-Source Charge | Q_gs | | | | - | 6 | - | | |
| Gate-Drain Charge | Q _{gd} | | | | - | 11 | - | | |
| Turn-On Delay Time | t _{d(on)} | _ | - | | - | 18 | 36 | | |
| Rise Time | t _r | $V_{DD} = 520V, I_D = 8 A,$ $V_{GS} = 10 V, R_g = 9.1 \Omega$ | | - | 24 | 48 | ns | | |
| Turn-Off Delay Time | t _{d(off)} | | | - | 48 | 96 | | | |
| Fall Time | t _f | | | - | 25 | 50 | | | |
| Gate Input Resistance | R _g | t = 1 | MHz, ope | n drain | - | 0.8 | - | Ω | |
| Drain-Source Body Diode Characteristic | cs | 1 | | | 1 | | | | |
| Continuous Source-Drain Diode Current | I _S | MOSFET symbol showing the integral reverse p - n junction diode | | - | - | 15 | A | | |
| Pulsed Diode Forward Current | I _{SM} | | | - | - | 38 | | | |
| Diode Forward Voltage | V _{SD} | T _J = 25 °C, I _S = 8 A, V _{GS} = 0 V | | - | - | 1.2 | V | | |
| Reverse Recovery Time | t _{rr} | | | | - | 325 | - | ns | |
| Reverse Recovery Charge | Q _{rr} | T _J = 25 °C, I _F = I _S = 8 A, dl/dt = 100 A/μs, V _R = 400 V | | - | 4.6 | - | μC | | |
| Reverse Recovery Current | I _{RRM} | | | - | 20 | - | A | | |
| | 'NKIVI | | | | | | | | |

Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

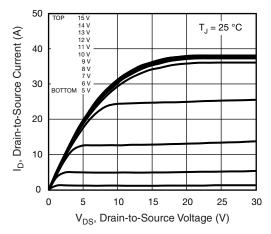


Fig. 1 - Typical Output Characteristics

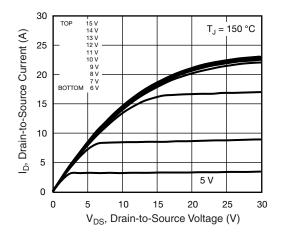


Fig. 2 - Typical Output Characteristics

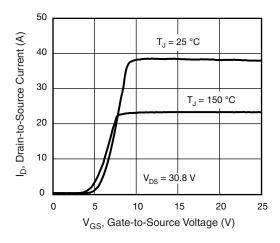


Fig. 3 - Typical Transfer Characteristics

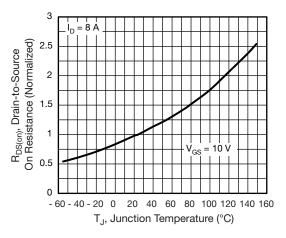


Fig. 4 - Normalized On-Resistance vs. Temperature

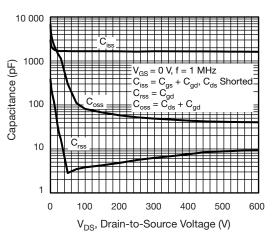


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

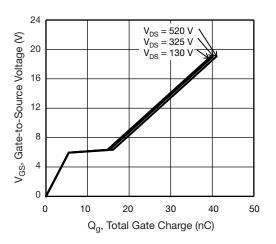


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

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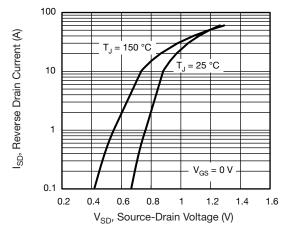


Fig. 7 - Typical Source-Drain Diode Forward Voltage

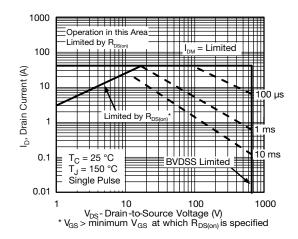


Fig. 8 - Maximum Safe Operating Area

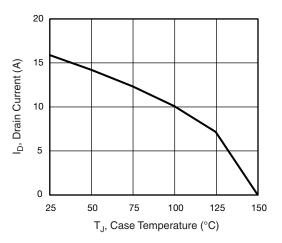


Fig. 9 - Maximum Drain Current vs. Case Temperature

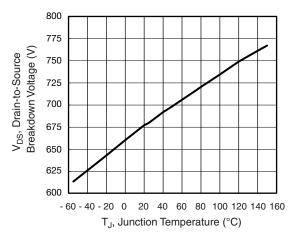


Fig. 10 - Temperature vs. Drain-to-Source Voltage

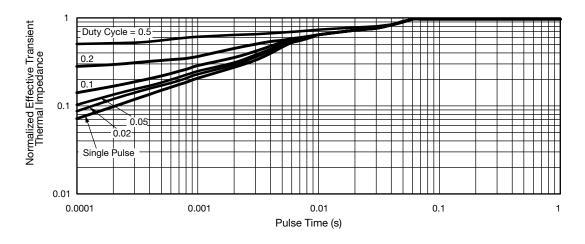


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



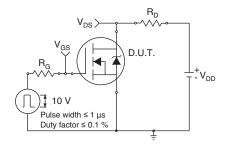


Fig. 12 - Switching Time Test Circuit

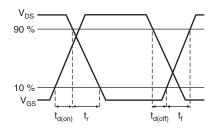


Fig. 13 - Switching Time Waveforms

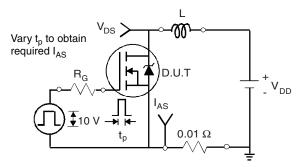


Fig. 14 - Unclamped Inductive Test Circuit

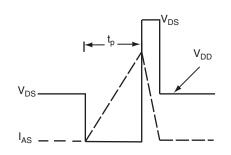


Fig. 15 - Unclamped Inductive Waveforms

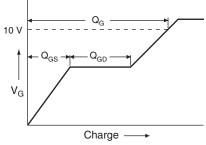


Fig. 16 - Basic Gate Charge Waveform

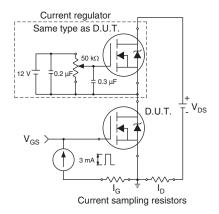
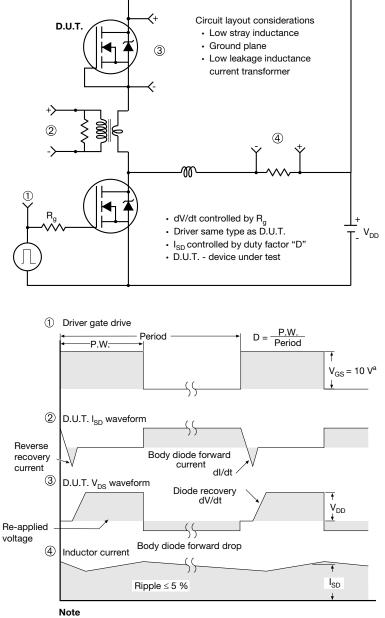


Fig. 17 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

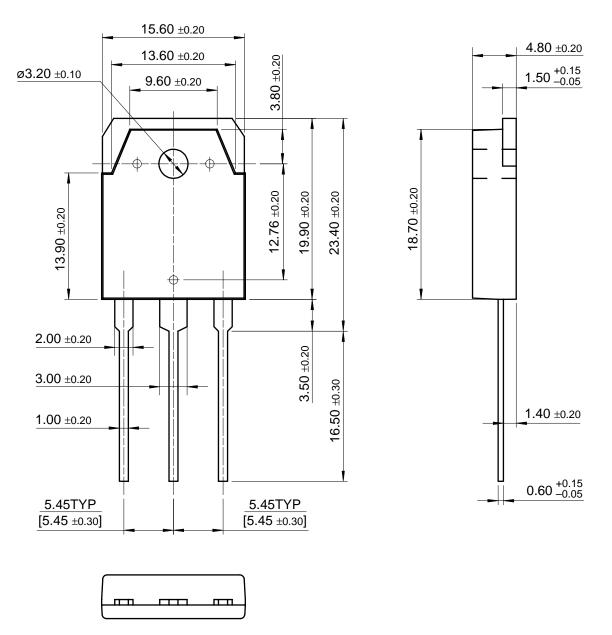


a. $V_{GS} = 5$ V for logic level devices

Fig. 18 - For N-Channel



TO-3P





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